

PRODUCT SPECIFICATION

CKM PN: 2501 Series

2.50mm PITCH CONNECTOR

REVISION HISTORY:

REV	REVISION DESCRIPTION	DATE	CREATED/REVISED
А	NEW RELEASE	2006.04.03	
В	UPGRADE THE FORM	2013.10.20	Qinggang yang
С	UPGRADE THE FORM	2014.09.09	Guobao Lee
D	UPDATE THE MAXIMUM OPERATING TEMPERATURE	2015.10.28	Zisen Wei
Е	UPDATE TEST REQUIREMENTS AND PROCEDURES	2015.11.23	Zisen Wei
F	UPDATE THE FORM	2015.12.08	Zisen Wei
G	Update Data	2019.04.11	Odyssey

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PS-2501-001		Odyssey Sun Lee Angus			us Chen	



1.0. SCOPE

This product specification covers performance, tests and quality requirements for **2501** Connector Series When tests are performed on subject product line, procedures specified in Figure 1 shall be used. All inspections shall be performed using the applicable product drawing.

2.0. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of the specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

2.1. APPLICABLE DOCUMENTS AND SPECIFICATIONS

EIA-364 UL-94 Flammability JIS C5402 JIS C0020,C0021

MIL-STD-202

3.0.REQUIREMENTS

3.1Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing

3.2 MATERIAL

Materials used in the construction of this product shall be as specified on the applicable product drawing 3.3 Ratings

1. Rated Voltage: 250 V AC DC

2. Rated Current: 2.5A(#22 AWG)

2A (#24 AWG)

1.5Å (#26 AWG)

1.25Å(#28 AWG)

3. Current: See Figure 4 for applicable current carrying capability. Maximum rated current that can be carried by this product is limited by maximum operating temperature of the housings (85°C) and temperature rise of the housings (30°C). Variables to be considered for each application are: wire size, connector size, contact material, ambient temperature, and printed circuit board design.

4. Ambient Temperature Range: -25 to 85°C

3.4 Performance and Test Description.

Product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions.

3.5 Test Requirements and Procedures Summary

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Test Descri	ption	Require	ment		Procedu	re		
Initial examina product.	ation of	Meets requirements of product drawing and Application		EIA- per p	364-18.Visual and dimens product drawing	ional (C c	of C)inspection	
Final exami of product.	ination	Meets visual require	ements.	EIA-364-18.Visual inspection.				
			ELECTR	ICAL				
Low Lev Contact Resista (LLCR).	10 mΩ maximum maximum final.	initial.40 mΩ		EIA-364-23.Subject spect maximum and 20 mV ma voltage. See Figure 3.	cimens to aximum o	0 100 mA open circuit		
Insulation 1000 MΩ minimum resistance.				EIA-364-21.500 V DC, 1 minute hold. Test between adjacent contacts.			old. Test	
Withsta voltage.	nding	One minute ho breakdown or 5mA maxir cur	old with no flashover. num leakage rrent.		EIA-364-20, Condition I. Test between adjacent c	500 V A0 ontacts.	C at sea level.	
Temper rise vs current.	ature	30°C maximum tem specified c	perature rise at urrent.		EIA-364-70, Method 1.S current level until 3 read intervals are within 1°C.S	tabilize a ings at 5 See Figui	t a single minute ⁻ e 4.	
			MECHAN	IICAL				
Durabil	Durability. See N			El/ with	A-364-9.Manually mate an companion headers for 30 rate of 25±3 mm	d un mat) cycles a per minut	e specimens at a maximum te	
	E 0.0 /							
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Mating fo	erce.	See fig	ure1	spec mm	EIA-364-13.Measure force imens with companion hea from point of initial contac 25±3 mm per r	e necessa aders a d t at a ma minute.	ary to mate istance of 5.08 ximum rate of	
Un mating	force.	See fig	ure1	E spe	EIA-364-13.Measure force necessary to un mate specimens from companion headers at a maximum rate of 25±3 mm per minute			
Terminal / Ho Retention F (For Plug	/ Housing on Force 1.0kgf Min. Plug)			Retention speed 25±3 mm per minute from housing			from housing	
Contact rete (for Head	Contact retention. 1.0kgf minimum P (for Header)				n pin from insulator base a te	t speed 2	25± 3 mm per	
Vibration Vibration Appearance: No dam Contact resistance: 40m Discontinuity: 1 micro second ma			No damage; e: 40mΩ Max; nuity: ond max.		Amplitude: 0. Sweep Time: 10-55- Duration: 2 Hours in e (Based upon MIL-STD-2	.75mm 10 Hz/m each X,Y, 202 Meth	inute Z axils iod 201)	
Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock Mechanical Shock			damage ontinuity greater shall occur esistance: After test		Subject mated conne (peak value) half-sine 11 ms duratior shocks in each dire applied along the th perpendicular axe specimen (18 shocks) load condition sha maximum for all	ctors to s shock pu n. Three ction sha aree mutu s of the t). The ele II be 100 contacts	50 G's Ilses of Jally est ectrical mA	
			ENVIRONM	IENTA	AL.			
Heat Resist	ance	No Physical & Contact res 40 m Ω Max /	damage sistance: After test	ten	Subject mated con nperature life at 85± 2℃ fc Signal.	nectors t or 96 hou	to rs. Measure	
Cold Resist	ance	No physical & Contact res 40 mΩ Max A	damage sistance: After test		Mate connectors: Duration: 96 hours; Temperature: -25 ± 2°C			
No physical of Contact resistance after te Insulation resistanc Dielectric withstan		damage : 40 mΩ Max. st e: 10 MΩ Min. ding voltage: lown	Subj P.C. tempe It sh cond be ma	ect mated plug and conne Board, to relative humidity erature of $60^{\circ}C \pm 2^{\circ}C$ relativ all be subjected to standar lition for 1 hour after which ade.	ector, solo / 90~95% e humidi nd atmos n measur	dered to 6RH and a ty for 96 hour. pheric rements shall		
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Temperature cycling	Appearance: No damage Contact resistance: 40 mΩ Max.	Mated connector shall be set to temperature cycling for 5 cycles of which 1 cycle consists of: a) +25°C ~ 3 minutes b) -25°C ~ 30 minutes c) +25°C ~ 3 minutes d) +85°C ~ 30 minutes (Based upon JIS C5402 7.2)
Salt spray	Appearance: No damage	Mated connector shall be placed on a salt spray chamber on the following conditions. (Based upon JIS C5402 7.1 / MIL-STD-202 Method 101 Condition B) Salt Solution Density : 5±1% Temperature : 35±2°C, Duration : 12Hours
Solder ability	Solder coverage: 95% Min.	Subject the test area of contacts into the flux for 5-10 sec. And then into solder bath, Temperature at $245 \pm 5^{\circ}$ C for 3 ± 0.5 sec.
Resistance to Soldering Heat (for Header)	No damage	for wave soldering :MIL-STD-202F, Method 210A, Test Condition B. Pre-heat : 80° C, 60 Seconds Temperature : $260\pm5^{\circ}$ C Immersion duration : 10 ± 1 sec. See figure 5
Soldering iron method	No damage	Apply solder iron in solder tail Temperature: 350°C Max, 3 sec.

Figure 1

4.Mating and Un-mating Force(Retain Latch):

DIN No	At	At 30th	
FIIN INO.	Mating (kgf Max.)	Un-mating (kgf Min.)	Un-mating (kgf Min.)
2	3.5	0.8	0.6
3	4.0	1.0	0.8
4	4.5	1.2	0.9
5	5.0	1.2	0.9
6	5.5	1.4	1.0
7	6.0	1.4	1.0
8	6.5	1.6	1.2
9	7.0	1.6	1.2
10	7.5	1.8	1.4

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11	8.0	1.8	1.4	
12	8.5	2.0	1.6	
13	9.0	2.0	1.6	
14	9.5	2.2	1.8	
15	10.0	2.4	2.0	

5. Crimping Specification:

Fix the crimped terminal, apply axial pull out force on the wire at a constant speed of 25±3mm/min (Based upon JIS C5402 6.22)

2501T0X-XX									
Wire Size(A	AWG)	#22 #24 #26 #28							
1 CONDUCTOD (mm)	CRIMP WIDTH	1.50±0.1							
1. CONDUCTOR (mm)	CRIMP HEIGHT	0.74~0.85	0.69~0.78	0.63~0.72	0.59~0.68				
	CRIMP WIDTH	1.80							
2. INSULATION (mm)	CRIMP HEIGHT	1.92	1.85	1.81	1.75				
CRIMP STRE	ENGTH	4.0Kgf (MIN)	3.0Kgf (MIN)	2.0Kgf (MIN)	1.5Kgf (MIN)				

NOTE

Shall meet visual requirements, show no physical damage, and meet requirements of additional tests as specified in the Product Qualification and Requalification Test Sequence shown in Figure2.

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						Test	Group					
Test or Examination	n A	В	С	D	Е	F	G	Н	Ι	J	K	L
					Т	est Se	quence (a	a)				
Examination of Product	1,5	1,7	1	1	1,5	1,3	1,5	1,6	1,3	1,3	1,3	1,5
Contact Resistance	2,6	2,8			2,4		2,4	2,5				2,4
Insulation Resistance		3,9										
Dielectric withstanding Voltag	e	4,10										
Temperature Rise						2						
Durability	4											
Mating & Un-mating force	g 3											
Terminal/Housing Insertion Force (Fo Plug)	r			2								
Contact retention. (for Header)			2									
Vibration					3							
Mechanical Shock												3
Heat Resistance								3				
Cold Resistance								4				
Humidity		6										
Temperature cycling	3	5										
Salt spray									2			
Solder ability	_									2		
heat	/						3					
Soldering iron method											2	
Sample Size	5	5	5	5	5	5	5	5	5	5	5	
				I	Figure	2						
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NOTE:

(a)See paragraph 6.1.A.

(b)Numbers indicate sequence in which tests are performed. (c)Precondition specimens with 30 durability cycles.

6. QUALITY ASSURANCE PROVISIONS

6.1 Qualification Testing

A .Specimen Selection

Specimens shall be prepared in accordance with applicable Instruction Sheets and shall be selected at random from current production. Test groups 1, 2, 3 and 5 shall each consist of a minimum of 5 specimens with a minimum of 30 data points. Test group 4 shall consist of a minimum of 5 specimens with a minimum of 30 header posts

B. Test Sequence

Qualification inspection shall be verified by testing specimens as specified in Figure 2.

6.2 Requalification Testing

If changes significantly affecting form, fit or function are made to the product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of the original testing sequence as determined by development/product, quality and reliability engineering.

6.3 Acceptance

Acceptance is based on verification that the product meets the requirements of Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and specimens resubmitted for qualification. Testing to confirm corrective action is required before resubmitted.

6.4 Quality Conformance Inspection

The applicable quality inspection plan shall specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification



Figure 3 LLCR Measurement Points

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